

# OptiMOS™-5 Power-Transistor





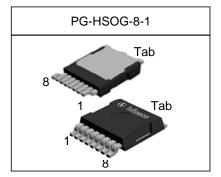
### **Features**

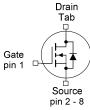
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- Ultra low Rds(on)
- 100% Avalanche tested

Туре	Package	Marking	
IAUS165N08S5N029	PG-HSOG-8-1	A08S5N29	

$V_{ m DS}$	80	٧
R <sub>DS(on)</sub>	2.9	mΩ
I <sub>D</sub>	165	Α

**Product Summary** 





### **Maximum ratings,** at $T_i$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	$T_{\rm C}$ =25°C, $V_{\rm GS}$ =10V <sup>1)</sup>	165	А
		T <sub>C</sub> =100 °C, V <sub>GS</sub> =10 V <sup>2)</sup>	120	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	660	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	/ <sub>D</sub> =83 A	225	mJ
Avalanche current, single pulse	IAS	-	165	А
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	167	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	-	0.9	K/W

# **Electrical characteristics**, at $T_{\rm j}$ =25 °C, unless otherwise specified

### Static characteristics

Drain-source breakdown voltage <sup>2)</sup>	$V_{(BR)DSS}$	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =1 mA	80	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 108  \mu {\rm A}$	2.2	3	3.8	
Zero gate voltage drain current <sup>2)</sup>	I <sub>DSS</sub>	$V_{\rm DS} = 80 \text{ V}, V_{\rm GS} = 0 \text{ V}, $ $T_{\rm j} = 25 \text{ °C}$	ı	0.1	1	μΑ
		$V_{\rm DS}$ =50 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =85 °C <sup>2)</sup>	-	1	20	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =6 V, I <sub>D</sub> =40 A	-	2.9	4.4	mΩ
		V <sub>GS</sub> =10 V, I <sub>D</sub> =80 A	-	2.4	2.9	



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	Ciss		-	4900	6370	pF
Output capacitance	Coss	$V_{GS}$ =0 V, $V_{DS}$ =40 V, $f$ =1 MHz	-	790	1027	1
Reverse transfer capacitance	C <sub>rss</sub>		-	36	54	
Turn-on delay time	t <sub>d(on)</sub>		-	13	-	ns
Rise time	t <sub>r</sub>	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G}$ =3.5 $\Omega$	-	9	-	
Turn-off delay time	$t_{\text{d(off)}}$		-	23	-	
Fall time	$t_{f}$	]	-	29	-	
Gate Charge Characteristics <sup>2)</sup>		T			Т	
Gate to source charge	Q <sub>gs</sub>		-	24	31	nC
Gate to drain charge	Q <sub>gd</sub>	V <sub>DD</sub> =40 V, I <sub>D</sub> =100 A,	-	15	23	_
Gate charge total	$Q_g$	V <sub>GS</sub> =0 to 10 V	ı	70	90	
Gate plateau voltage	V <sub>plateau</sub>		-	5.0	-	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	Is	T _25 °C	_	-	165	Α
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	-T <sub>C</sub> =25 °C	-	-	660	
Diode forward voltage	$V_{SD}$	V <sub>GS</sub> =0 V, I <sub>F</sub> =100 A, T <sub>j</sub> =25 °C	-	0.9	1.2	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	V <sub>R</sub> =40 V, I <sub>F</sub> =50A,	-	60	-	ns
Reverse recovery charge <sup>2)</sup>	Qrr	d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/µs	-	96	-	nC

 $<sup>^{1)}</sup>$  Current is limited by bondwire; with an  $R_{\rm thJC}$  = 0.9 K/W the chip is able to carry 171A at 25°C.

 $<sup>^{2)}\,\</sup>mbox{Defined}$  by design. Not subject to production test.

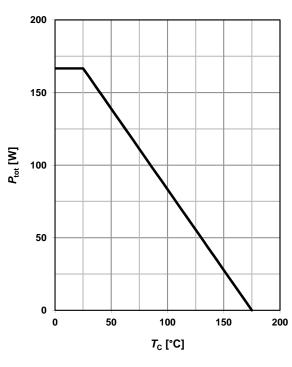


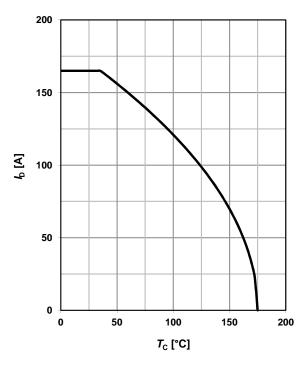
### 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); \ V_{\text{GS}} \ge 6 \text{ V}$$

# 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}$$





### 3 Safe operating area

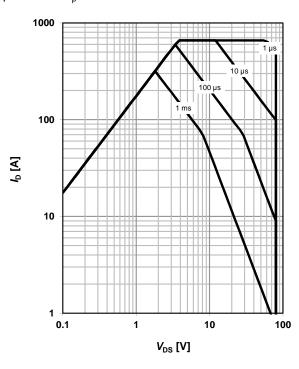
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

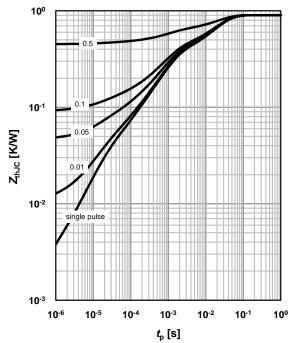
parameter:  $t_{\rm p}$ 

### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_{p})$$

parameter:  $D=t_p/T$ 







### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ }^{\circ}\text{C}$ 

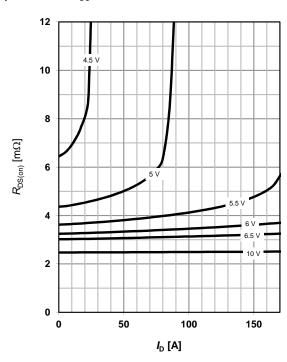
parameter:  $V_{\rm GS}$ 

# 525 525 175 0 1 2 3 4 5 6 7 V<sub>DS</sub> [V]

## 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ °C}$ 

parameter:  $V_{\rm GS}$ 



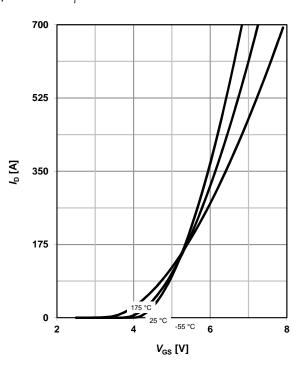
### 7 Typ. transfer characteristics

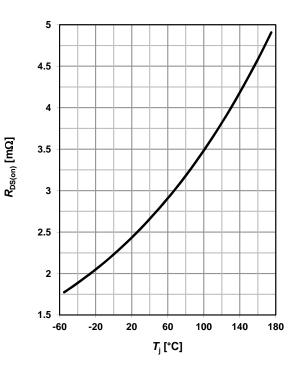
 $I_D = f(V_{GS}); V_{DS} = 6V$ 

parameter:  $T_{\rm j}$ 

### 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}$$







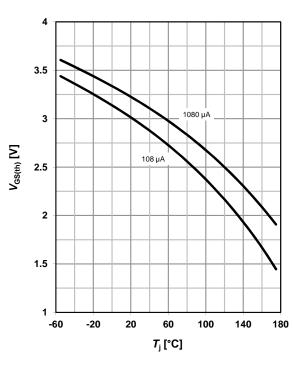
### 9 Typ. gate threshold voltage

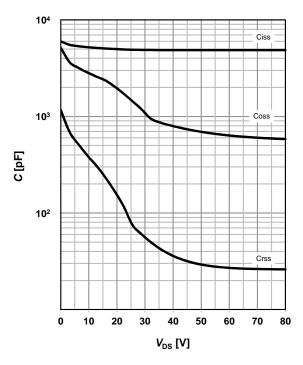
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_D$ 

# 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$ 





### 11 Typical forward diode characteristicis

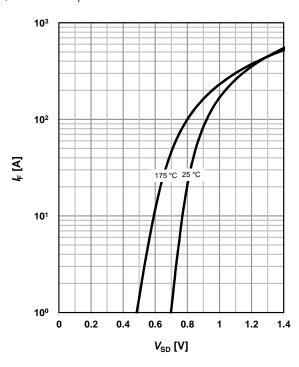
 $IF = f(V_{SD})$ 

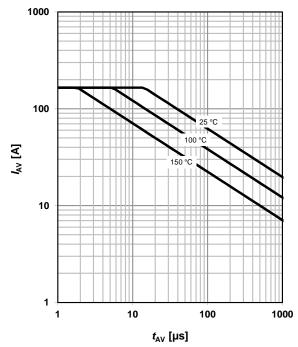
parameter:  $T_{\rm j}$ 

### 12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>j(start)</sub>







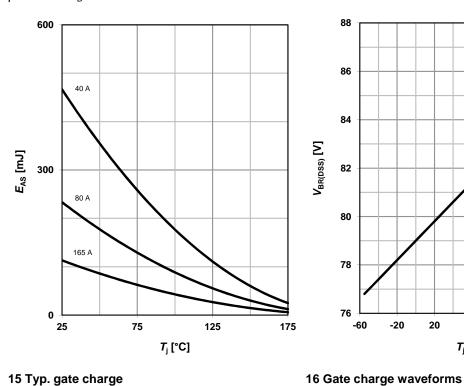
### 13 Typical avalanche energy

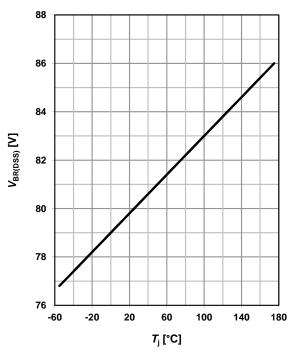
### $E_{AS} = f(T_j)$

parameter: I<sub>D</sub>

### 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_{D_typ} = 1 \text{ mA}$$

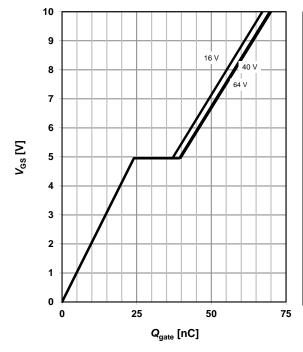


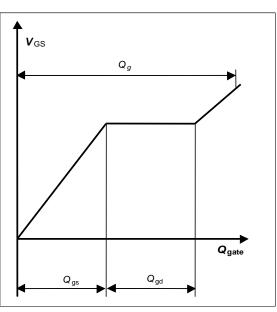


## 15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 100 A pulsed$ 

parameter:  $V_{\rm DD}$ 







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**Revision History** 

Version	Date	Changes	
Version 1.0	4/10/2018	Final Data Sheet	